

• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- DC-DC
- Load Switch

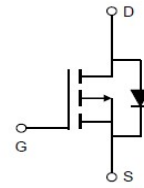
• Ordering Information:

| | |
|---------------------------|-----------|
| Part NO. | ZM900P10M |
| Marking | 900P10 |
| Packing Information | REEL TAPE |
| Basic ordering unit (pcs) | 5000 |

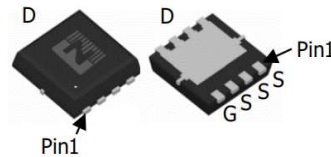
• Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

| Parameter | Symbol | Conditions | Value | Unit |
|----------------------------------|-----------|---|-------------|------------------|
| Drain-Source Voltage | V_{DS} | $25^\circ\text{C} \leq T_J \leq 175^\circ\text{C}$ | -100 | V |
| Gate-Source Voltage ^① | V_{GS} | | ± 20 | V |
| Continuous Drain Current | I_D | $T_C=25^\circ\text{C}$ | -10.6 | A |
| | I_D | $T_C=75^\circ\text{C}$ | -8.3 | A |
| | I_D | $T_C=100^\circ\text{C}$ | -6.8 | A |
| Pulsed Drain Current | I_{DM} | Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$; | -42.4 | A |
| Total Power Dissipation | P_D | $T_C=25^\circ\text{C}$ | 35 | W |
| Total Power Dissipation | P_D | $T_A=25^\circ\text{C}$ | 2.1 | W |
| Operating Junction Temperature | T_J | | -55 to +150 | $^\circ\text{C}$ |
| Storage Temperature | T_{STG} | | -55 to +150 | $^\circ\text{C}$ |
| Single Pulse Avalanche Energy | E_{AS} | L=0.1mH, VGS=10V, Rg=25 Ω , | 50 | mJ |
| | | L=0.5mH, VGS=10V, Rg=25 Ω , | 105 | mJ |
| ESD Level (HBM) | | | CLASS 2 | |

• Product Summary



$V_{DS} = -100\text{V}$
 $R_{DS(ON)} = 110\text{m}\Omega$
 $I_D = -10.6\text{A}$



DFN3*3



•Thermal resistance

| Parameter | Symbol | Min. | Typ. | Max. | Unit |
|---|------------|------|------|------|------|
| Thermal resistance, junction - case | R_{thJC} | | - | 3.6 | °C/W |
| Thermal resistance, junction-ambient ^② | R_{thJA} | | - | 60 | °C/W |
| Soldering temperature (total time<10s) | T_{sold} | | - | 260 | °C |

•Electronic Characteristics

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
|-----------------------------------|--------------|-----------------------------------|------|------|------|------------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS} = 0V, I_D = 250\mu A$ | -100 | | | V |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS} = V_{DS}, I_D = 250\mu A$ | -1.3 | -1.8 | -2.5 | V |
| Drain-Source Leakage Current | I_{DSS} | $V_{GS} = 0V, V_{DS} = -100V$ | | | 1.0 | μA |
| Gate- Source Leakage Current | I_{GSS} | $V_{GS} = \pm 20V, V_{DS} = 0V$ | | | 100 | nA |
| Static Drain-source On Resistance | $R_{DS(ON)}$ | $V_{GS} = 10V, I_D = -8A$ | | 110 | 145 | m Ω |
| | | $V_{GS} = 4.5V, I_D = -6A$ | | 125 | 165 | m Ω |
| Forward Transconductance | g_{FS} | $V_{GS} = 5V, I_{SD} = -6A$ | | 15 | | S |
| Diode Forward Voltage | V_{FSD} | $V_{GS} = 0V, I_{SD} = -8A$ | | | 1.3 | V |

•Dynamic characteristics

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit | |
|------------------------------|----------------------|---|----------|------|------|----------|---|
| Input capacitance | C_{iss} | $f = 1MHz, V_{DS} = -25V$ | - | 2330 | - | pF | |
| Output capacitance | C_{oss} | | - | 94 | - | | |
| Reverse transfer capacitance | C_{rss} | | - | 46 | - | | |
| Gate Resistance | R_g | $f = 1MHz$ | - | 13 | | Ω | |
| Total gate charge | Q_g | $V_{DD} = -15V, I_D = -8A, V_{GS} = -10V$ | - | 30 | - | nC | |
| | $Q_g(-4.5v)$ | | - | 21 | - | | |
| | Gate - Source charge | | Q_{gs} | - | 6.8 | | - |
| | Gate - Drain charge | | Q_{gd} | - | 3.3 | | - |
| Turn-ON Delay time | $t_{D(on)}$ | $V_{GS} = -10V, V_{DS} = -15V, R_G = 3.3\Omega, I_D = -10A$ | - | 8 | - | ns | |
| Turn-ON Rise time | t_r | | - | 16 | - | ns | |
| Turn-Off Delay time | $t_{D(off)}$ | | - | 55 | - | ns | |
| Turn-Off Fall time | t_f | | - | 30 | - | ns | |

Fig.1 Gate-Charge Characteristics

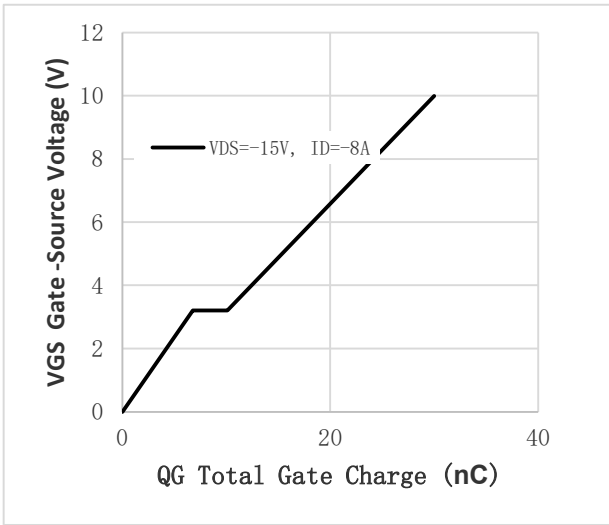


Fig.2 Capacitance Characteristics

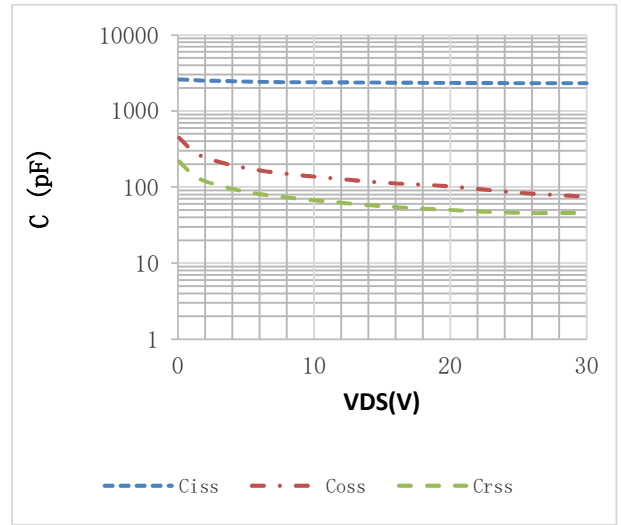


Fig.3 Power Dissipation

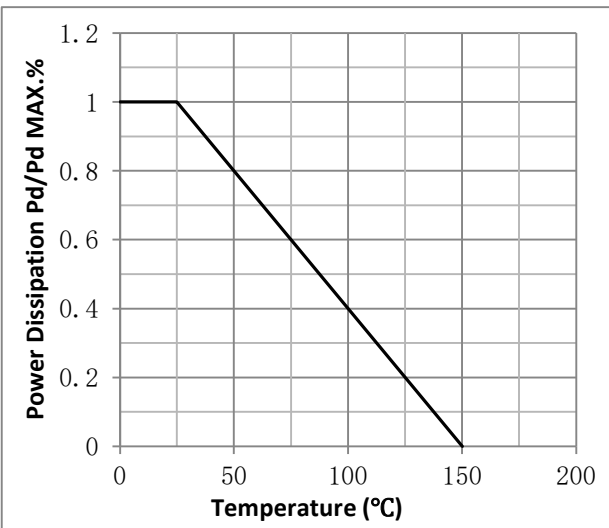


Fig.4 Typical output Characteristics

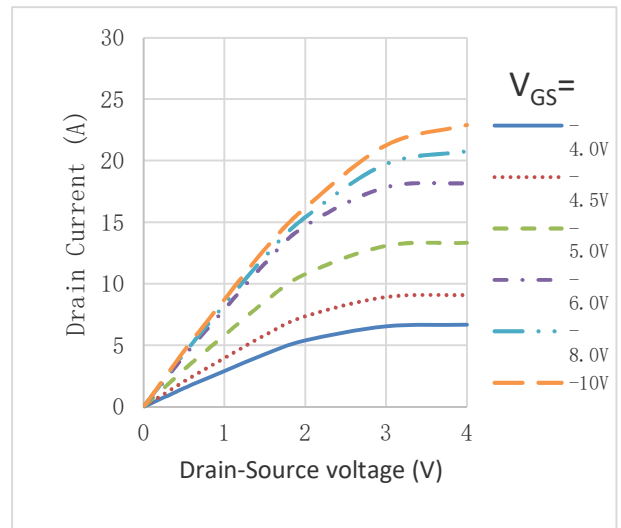


Fig.5 Threshold Voltage V.S Junction Temperature

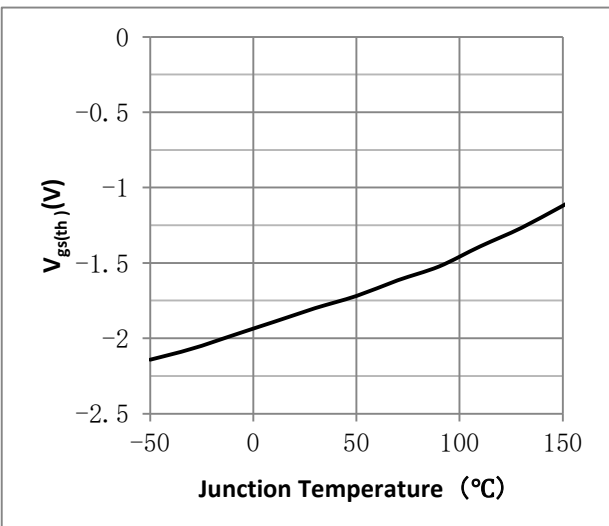


Fig.6 Resistance V.S Drain Current

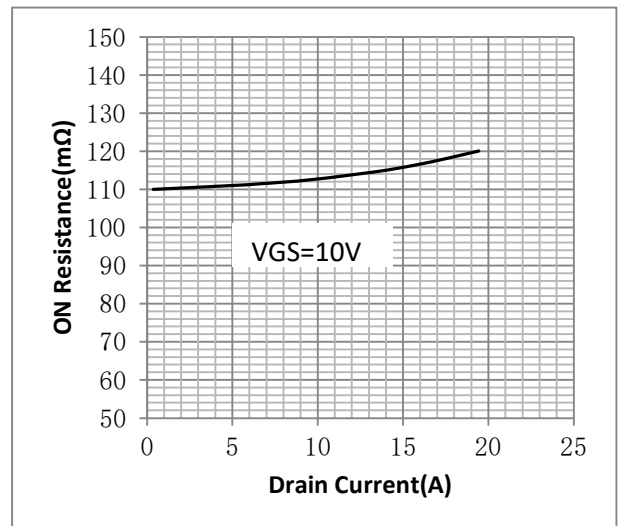


Fig.7 On-Resistance VS Gate Source Voltage

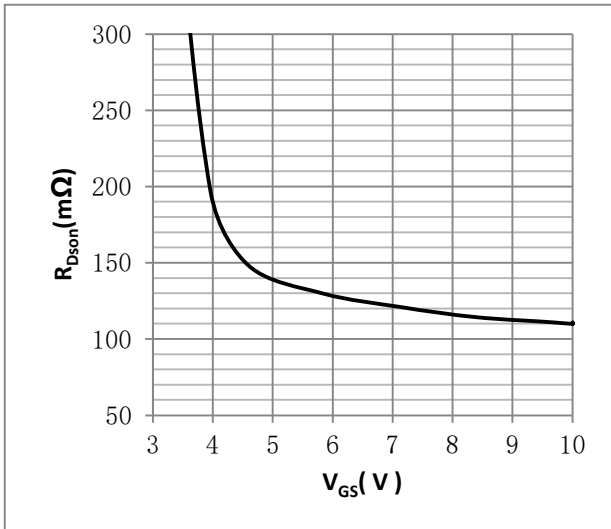


Fig.8 On-Resistance V.S Junction Temperature

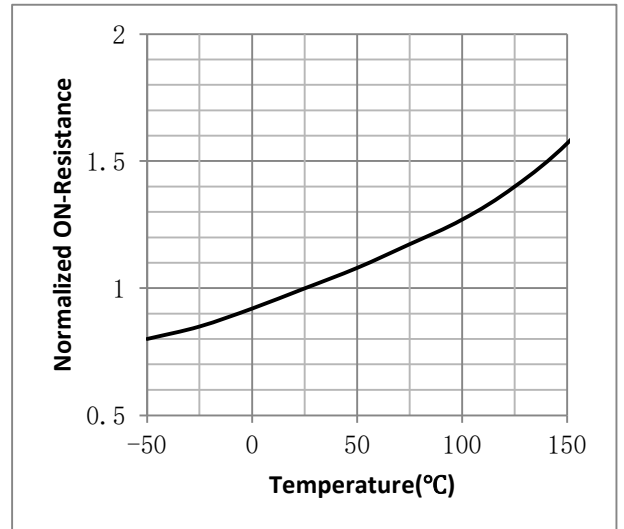


Figure 9. Diode Forward Voltage vs. Current

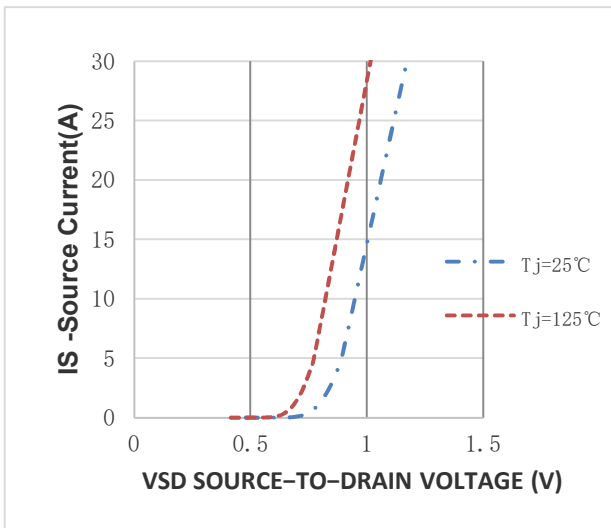


Figure 10. Transfer Characteristics

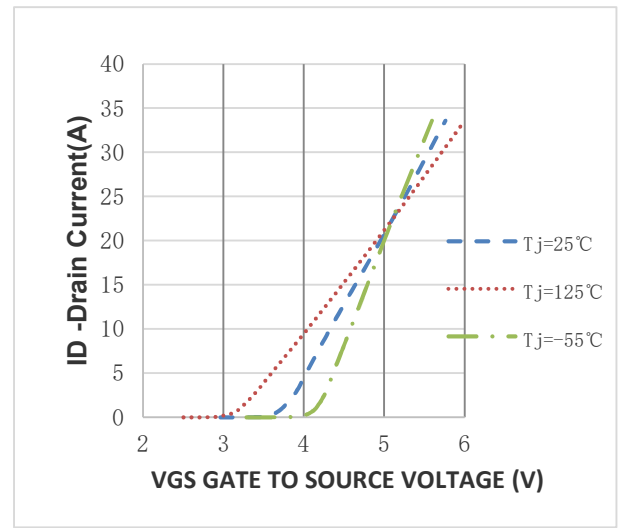


Fig.11 SOA Maximum Safe Operating Area

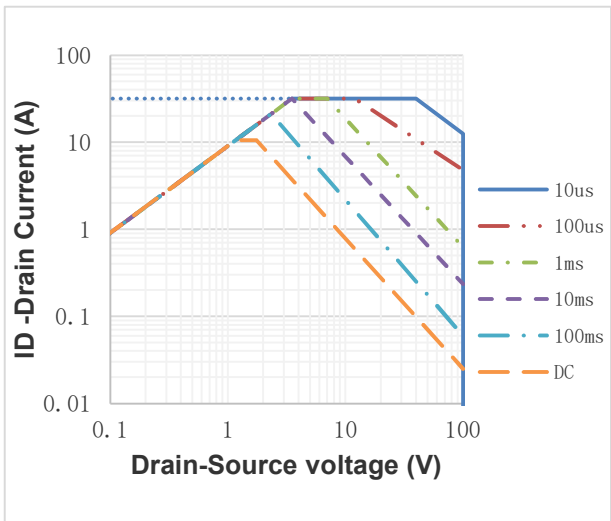
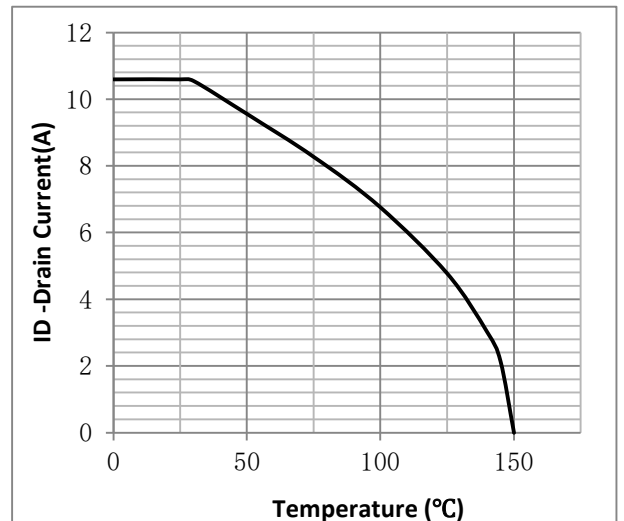
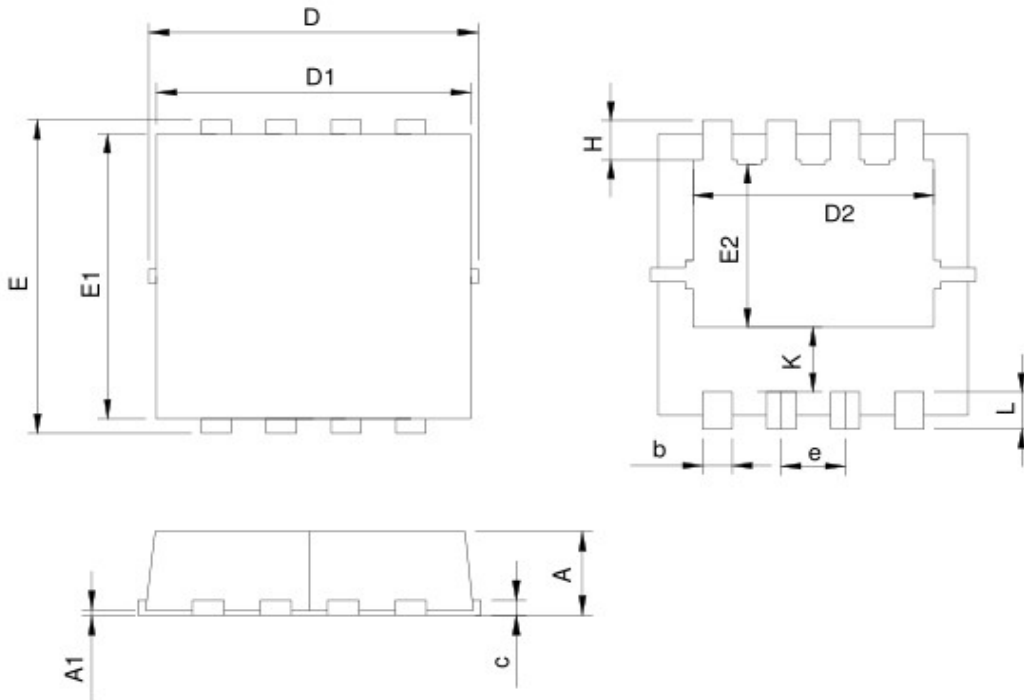


Fig.12 ID vs. Case Temperature^③

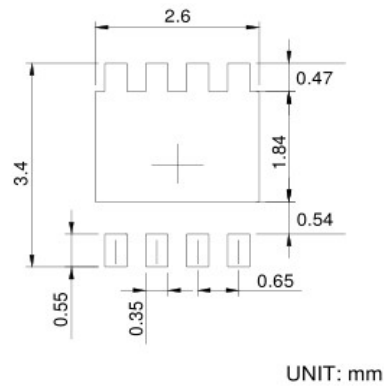


•DFN3*3 Package Outline



| SYMBOL | DFN3.3x3.3-8 | | | |
|--------|--------------|------|-----------|-------|
| | MILLIMETERS | | INCHES | |
| | MIN. | MAX. | MIN. | MAX. |
| A | 0.70 | 1.00 | 0.028 | 0.039 |
| A1 | 0.00 | 0.05 | 0.000 | 0.002 |
| b | 0.25 | 0.35 | 0.010 | 0.014 |
| c | 0.14 | 0.20 | 0.006 | 0.008 |
| D | 3.10 | 3.50 | 0.122 | 0.138 |
| D1 | 3.05 | 3.25 | 0.120 | 0.128 |
| D2 | 2.35 | 2.55 | 0.093 | 0.100 |
| E | 3.10 | 3.50 | 0.122 | 0.138 |
| E1 | 2.90 | 3.10 | 0.114 | 0.122 |
| E2 | 1.64 | 1.84 | 0.065 | 0.072 |
| e | 0.65 BSC | | 0.026 BSC | |
| H | 0.32 | 0.52 | 0.013 | 0.020 |
| K | 0.59 | 0.79 | 0.023 | 0.031 |
| L | 0.25 | 0.55 | 0.010 | 0.022 |

RECOMMENDED LAND PATTERN



Note:

- ① Pulse : $V_{GS}=+20V/-20V$, Duty cycle=50%, $T_j=175^{\circ}C$, $t=1000$ hours; For DC , the following test conditions can be passed: $V_{GS}=-20V/+10V$, $T_j=175^{\circ}C$, $t=1000$ hours ;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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Revision History

| Version | Date | Change |
|---------|-------------|---------------------------------------|
| A | 2021. 2. 3 | |
| B | 2022. 9. 7 | 1. Add Reach, HF figure, 2. ID modify |
| C | 2024. 6. 20 | Correct fig 3, 5, 8 |
| | | |
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